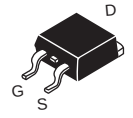
CEP9055/CEB9055
CEF9055

N-Channel Enhancement Mode Field Effect Transistor

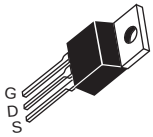
FEATURES

Type	V_{DSS}	$R_{DS(ON)}$	I_D	@V_{GS}
CEP9055	55V	10.5mΩ	100A	10V
CEB9055	55V	10.5mΩ	100A	10V
CEF9055	55V	10.5mΩ	100A [e]	10V

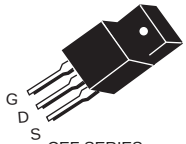
- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handing capability.
- Lead free product is acquired.
- TO-220 [g] & TO-263 package & TO-220F full-pak for through hole.



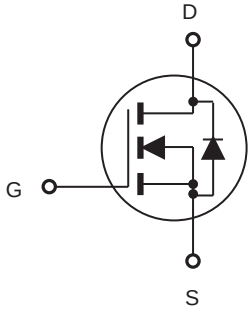
CEB SERIES
TO-263(DD-PAK)



CEP SERIES
TO-220



CEF SERIES
TO-220F



ABSOLUTE MAXIMUM RATINGS T_C = 25°C unless otherwise noted

Parameter	Symbol	Limit		Units
		TO-220/263	TO-220F	
Drain-Source Voltage	V_{DS}	55		V
Gate-Source Voltage	V_{GS}	±20		V
Drain Current-Continuous	I_D	100	100 [e]	A
Drain Current-Pulsed [a]	I_{DM} [f]	300	300 [e]	A
Maximum Power Dissipation @ T_C = 25°C	P_D	200	75	W
- Derate above 25°C		1.3	0.5	W/°C
Single Pulsed Avalanche Energy [d]	E_{AS}	325	325	mJ
Single Pulsed Avalanche Current [d]	I_{AS}	50	50	A
Operating and Store Temperature Range	T_J,T_{stg}	-55 to 175		°C

Thermal Characteristics

Parameter	Symbol	Limit		Units
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.75	2	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	65	°C/W

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} = 0V, I_D = 250μA	55			V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 55V, V_{GS} = 0V			10	μA
Gate Body Leakage Current, Forward	I_{GSSF}	V_{GS} = 20V, V_{DS} = 0V			100	nA
Gate Body Leakage Current, Reverse	I_{GSSR}	V_{GS} = -20V, V_{DS} = 0V			-100	nA
On Characteristics [b]						
Gate Threshold Voltage	$V_{GS(th)}$	V_{GS} = V_{DS}, I_D = 250μA	2		4	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	V_{GS} = 10V, I_D = 62A		8.8	10.5	mΩ
Forwand Transconductance	g_{FS}	V_{DS} = 25V, I_D = 62A		28		S
Dynamic Characteristics [c]						
Input Capacitance	C_{iss}	V_{DS} = 25V, V_{GS} = 0V, f = 1.0 MHz		2700		pF
Output Capacitance	C_{oss}			800		pF
Reverse Transfer Capacitance	C_{rss}			115		pF
Switching Characteristics [c]						
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 28V, I_D = 62A, V_{GS} = 10V, R_{GEN} = 4.5Ω		40	80	ns
Turn-On Rise Time	t_r			20	45	ns
Turn-Off Delay Time	$t_{d(off)}$			65	120	ns
Turn-On Fall Time	t_f			15	35	ns
Total Gate Charge	Q_g	V_{DS} = 44V, I_D = 62A, V_{GS} = 10V		60	80	nC
Gate-Source Charge	Q_{gs}			15		nC
Gate-Drain Charge	Q_{gd}			22		nC
Drain-Source Diode Characteristics and Maximun Ratings						
Drain-Source Diode Forward Current	I_S				62	A
Drain-Source Diode Forward Voltage [b]	V_{SD}	V_{GS} = 0V, I_S = 62A			1.3	V

Notes :
a.Repetitive Rating : Pulse width limited by maximum junction temperature
b.Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
c.Guaranteed by design, not subject to production testing.
d.L = 260μH, I_{AS} = 50A, V_{DD} = 30V, R_G = 25Ω, Starting T_J = 25℃
e.Limited only by maximum temperature allowed .
f .Pulse width limited by safe operating area .
g.The mounting torque (4-40/M3 screw) in TO-220 package is recommended within 3-4Kgf-cm (MAX. 4Kgf-cm)

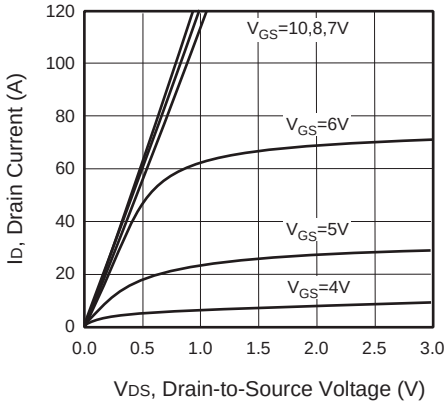


Figure 1. Output Characteristics

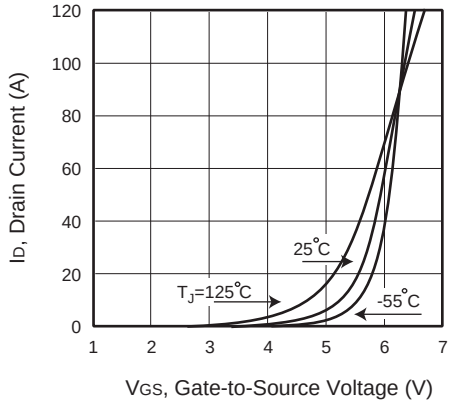


Figure 2. Transfer Characteristics

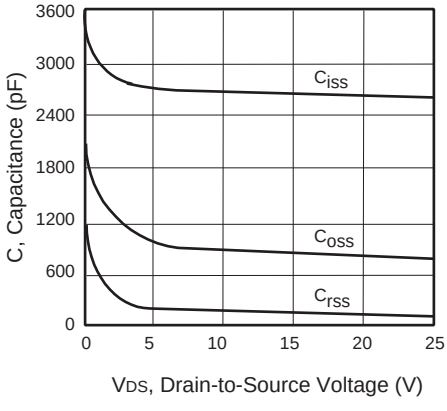


Figure 3. Capacitance

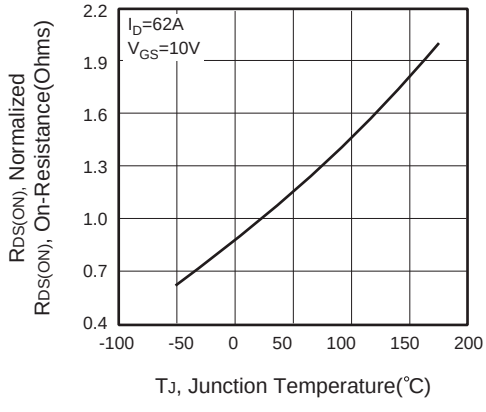


Figure 4. On-Resistance Variation with Temperature

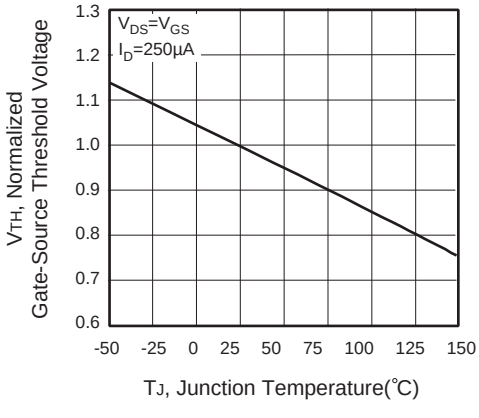


Figure 5. Gate Threshold Variation with Temperature

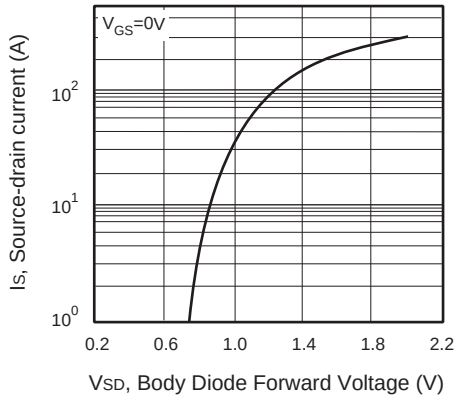


Figure 6. Body Diode Forward Voltage Variation with Source Current

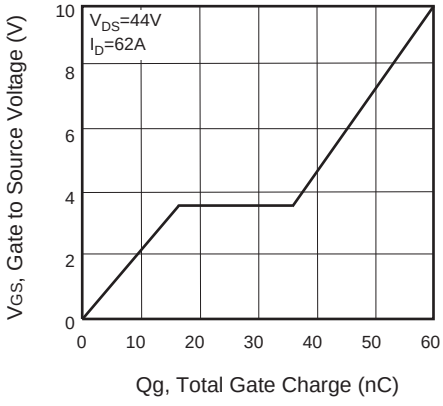


Figure 7. Gate Charge

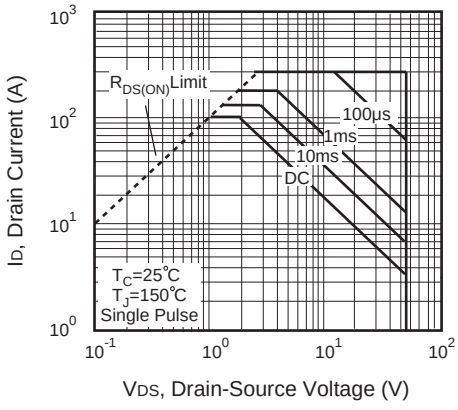


Figure 8. Maximum Safe Operating Area

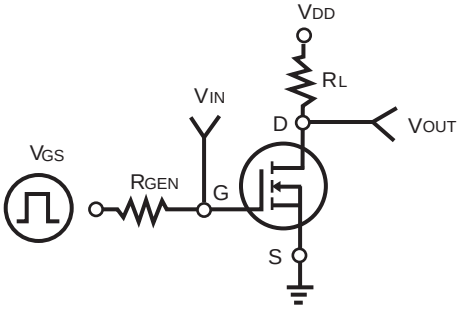


Figure 9. Switching Test Circuit

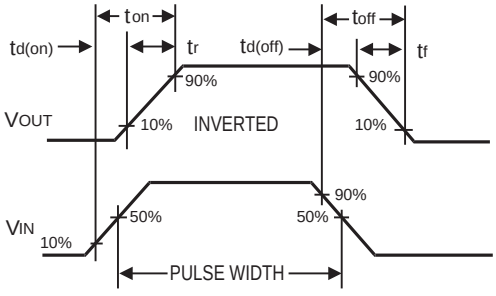


Figure 10. Switching Waveforms

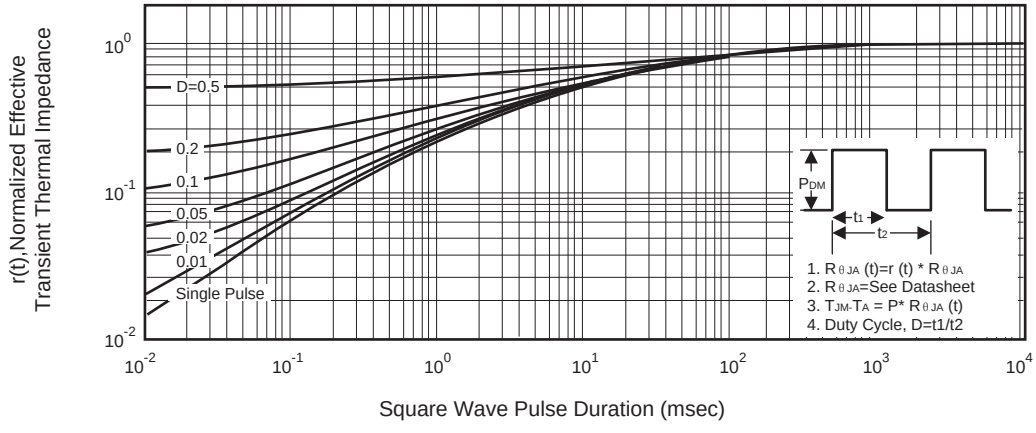


Figure 11. Normalized Thermal Transient Impedance Curve